

**Modulbezeichnung:** Scattering Methods for Nanostructured Materials (IMN\_M3/4/5/10/11-MWT\_M8/9/10/11-NT\_Scat) (Scattering Methods for Nanostructured Materials) **5 ECTS**

Modulverantwortliche/r: Erdmann Spiecker  
Lehrende: Erdmann Spiecker, Johannes Will

Startsemester: WS 2022/2023      Dauer: 1 Semester      Turnus: jährlich (WS)  
Präsenzzeit: 60 Std.      Eigenstudium: 90 Std.      Sprache: Deutsch und Englisch

**Lehrveranstaltungen:**

Scattering Methods for Nanostructured Materials (WS 2022/2023, Vorlesung, 2 SWS, Johannes Will et al.)  
Exercise Scattering Methods for Nanostructured Materials (WS 2022/2023, Übung, 2 SWS, Johannes Will)

**Inhalt:**

The module focuses on the application of scattering methods for crystal structure determination in general (diffraction), the investigation of supported nanostructures and thin films (grazing incidence diffraction and reflectometry) and for the size and shape analysis of nanostructures in solution (small-angle scattering). Basic concepts of Fourier transforms will be applied to the interaction of a primary probe with a periodically ordered object. Moreover, the impact of multiple scattering events on the diffracted intensity and its angular dependence will be discussed in a unified model for neutrons, x-rays and electrons. Those theoretical considerations will built the basis for the understanding of the methods named above. For all methods, current published research examples will be showcased.

**Lernziele und Kompetenzen:**

Die Studierenden

*Fachkompetenz*

*Verstehen*

- Basics of Fourier transform and convolution
- Understanding of the interaction of neutrons, x-rays and electrons with atoms and their arrays
- Physical principles of the interaction of a scattering probe with an extended crystalline lattice
- Understanding how scattering methods contribute and which kind of information can be extracted for today's challenges in material science

*Anwenden*

- Each topic will be accompanied with suitable exercises

**Literatur:**

D.S. Sivia: Elementary Scattering Theory B.E. Warren: X-ray Diffraction J. M. Cowley: Diffraction Physics A. Authier: Dynamical Scattering Theory Als-Nielsen & McMorrow: Elements of modern X-ray physics J. Daillant and A. Gibaud: X-ray and Neutron Reflectivity: Principles and Applications Renaud et al. 2009, Probing surface and interface morphology with Grazing Incidence Small Angle X-ray Scattering, Surface Science Reports 64, 255-380. Rivnay et al. 2012, Quantitative Determination of Organic Semiconductor Microstructure from the Molecular to Device Scale, Chem. Rev. 112, 5488-5519.

**Studien-/Prüfungsleistungen:**

Scattering Methods for Nanostructured Materials (Prüfungsnummer: 62851)

(englische Bezeichnung: Scattering Methods for Nanostructured Materials)

Prüfungsleistung, mündliche Prüfung, Dauer (in Minuten): 15

Anteil an der Berechnung der Modulnote: 100%

weitere Erläuterungen:

Prüfungssprache nach Wahl der Studierenden

Prüfungssprache: Deutsch oder Englisch

Erstablingung: WS 2022/2023, 1. Wdh.: SS 2023  
1. Prüfer: Erdmann Spiecker

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